

Dielectric screening of the Kohn anomaly of graphene on hexagonal boron nitrideF. Forster,^{1,2} A. Molina-Sanchez,^{3,4} S. Engels,^{1,2} A. Epping,^{1,2} K. Watanabe,⁵ T. Taniguchi,⁵ L. Wirtz,^{3,4} and C. Stampfer^{1,2}¹JARA-FIT and II. Institute of Physics, RWTH Aachen University, 52074 Aachen, Germany, EU²Peter Grünberg Institute (PGI-9), Forschungszentrum Jülich, 52425 Jülich, Germany, EU³Institute for Electronics, Microelectronics, and Nanotechnology (IEMN), CNRS UMR 8520, Department ISEN, 59652 Villeneuve d'Ascq Cedex, France, EU⁴Physics and Materials Science Research Unit, University of Luxembourg, L-1511 Luxembourg, Luxembourg, EU⁵National Institute for Materials Science, 1-1 Namiki, Tsukuba 305-0044, Japan

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Kohn anomalies in three-dimensional metallic crystals are dips in the phonon dispersion that are caused by abrupt changes in the screening of the ion cores by the surrounding electron gas. These anomalies are also present at the high-symmetry points Γ and K in the phonon dispersion of two-dimensional graphene, where the phonon wave vector connects two points on the Fermi surface. The linear slope around the kinks in the highest optical branch is proportional to the electron-phonon coupling. Here, we present a combined theoretical and experimental study of the influence of the dielectric substrate on the vibrational properties of graphene. We show that screening by the dielectric substrate reduces the electron-phonon coupling at the high-symmetry point K and leads to an upshift of the Raman 2D line. This results in the observation of a Kohn anomaly that can be tuned by screening. The exact position of the 2D line can thus be taken also as a signature for changes in the (electron-phonon limited) conductivity of graphene.

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I. INTRODUCTION

Graphene, a monoatomic carbon membrane with unique electronic properties,^{1,2} is a promising candidate for flexible electronics, high-frequency applications, and spintronics.³ However, graphene's ultimate surface-to-volume ratio makes the environment, in particular the substrate material, have a pronounced influence onto its intrinsic properties. For example, SiO₂, the most common substrate material, exhibits surface roughness, dangling bonds, and charge traps which introduce ripples, disorder,⁴ and doping domain fluctuations.⁵ This limits carrier mobilities and the operation of graphene devices.^{6,7} Therefore alternative substrates are required to overcome these limitations. Hexagonal boron nitride (hBN) has been identified as a very promising candidate.^{8–11} A large (indirect) band gap, a lattice mismatch to graphite of less than 2%, and the absence of dangling bonds makes this atomically flat material a valuable and promising insulating counterpart to graphene.^{12,13} It has been shown that graphene can be successfully transferred to ultrathin hBN flakes leading to improved electronic transport properties compared to graphene on SiO₂.^{8,9} Moreover, scanning tunneling microscopy experiments have shown that the sizes of individual electron-hole puddles are significantly increased while the disorder potential is reduced by roughly a factor 10.^{10,11}

Over the last years Raman spectroscopy has proven to be a powerful tool for characterizing graphene and studying its physical properties. For example, this technique has been successfully used (i) to distinguish single-layer graphene from few-layer graphene and graphite,^{16–18} (ii) to monitor doping levels,^{5,19} (iii) to study short-range disorder and edge properties,²⁰ and (iv) to investigate suspended²¹ and nanostructured graphene.²² Very recently, Raman measurements of graphene deposited on a hexagonal boron nitride (hBN) substrate have displayed subtle changes with respect to graphene on SiO₂.^{23,24} The G line was shown to downshift slightly by

about 4 cm⁻¹, a behavior that has also been observed for suspended graphene.²¹ This redshift was explained by the reduced doping level of suspended graphene and graphene on the pure hBN substrate. The 2D line, however, displays opposite behavior in the two cases: it displays a redshift in suspended graphene and a blueshift for graphene on hBN [and even more so for graphene embedded in hBN (Ref. 24)]. These shifts in opposite directions cannot be explained by the absence of impurities and have remained a puzzle up to now. The resolution of this effect is the aim of the current paper. We show here through a combined experimental and theoretical approach that the monoatomic layered structure of graphene renders the Kohn anomaly^{25,26} at the high-symmetry point K susceptible to the screening by the dielectric substrate. We present spatially resolved confocal Raman spectroscopy measurements of graphene on hexagonal boron nitride substrates which are compared with measurements of graphene on SiO₂.

II. MEASUREMENTS AND RESULTS**A. Sample Fabrication**

Graphene and hBN flakes are prepared by micromechanical cleavage. While hBN is directly deposited on a SiO₂/Si⁺⁺ substrate, graphene is prepared on top of a polymer stack consisting of a water-soluble polymer [100-nm polyvinylalcohol (PVA)] and a water resistant polymer [270-nm polymethyl methacrylate (PMMA)] allowing the transfer process described in detail in Ref. 8. Before depositing the graphitic flakes on top of the hBN, Raman spectroscopy has been used to identify and select individual single-layer graphene flakes.^{16,17} The Raman data are recorded by using a laser excitation of 532 nm ($E_L = 2.33$ eV) through a single-mode optical fiber whose spot size is limited by diffraction. A long working distance focusing lens with numerical aperture of 0.85 is used to obtain a spot size of approximately 400 nm. We used a

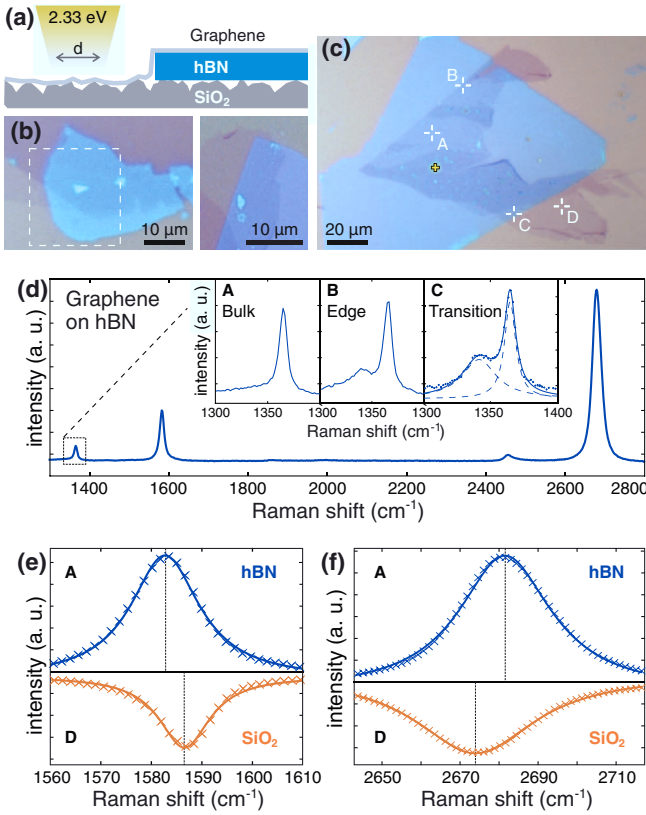


FIG. 1. (Color online) (a) Schematic illustration of a graphene sample with incident laser. (b),(c) Optical microscope images of graphene flakes partly resting on hBN (blue) and SiO₂. The flake consists of different regions of single-layer, bilayer, and few-layer graphene. (d) Raman spectrum of single-layer graphene resting on hBN. Inset: Region around the hBN peak at sites marked in panel (c). (e),(f) G (e) and 2D (f) peak of single-layer graphene on hBN (marker A) and SiO₂ (marker D).

laser power below 1 mW such that heating effects can be neglected.²⁷

B. Raman spectroscopy measurements

A schematic illustration of our structures is shown in Fig. 1(a) and optical microscope images of some fabricated samples are shown in Figs. 1(b) and 1(c). A typical Raman spectrum of a graphene flake resting on hBN is shown in Fig. 1(d). The Raman spectrum shows the prominent G line around 1582 cm⁻¹ as well as the single Lorentzian-shaped 2D line around 2675 cm⁻¹ as expected for graphene. A third prominent and sharp peak arises around 1365 cm⁻¹, which can be attributed to the Raman-active LO phonon in hBN.²⁸ It is important to distinguish this peak from the defect-induced D line potentially appearing at around 1345 cm⁻¹.¹⁷ Therefore, Raman spectra have been acquired at edge regions of the graphene flake where defects are known to appear.¹⁷ The insets in Fig. 1(d) show corresponding Raman spectra at different positions marked and labeled in Fig. 1(c). The data recorded at the edge (B) shows a second peak arising at around 1345 cm⁻¹ which is not visible in the bulk region and can be clearly distinguished from the one at 1365 cm⁻¹. As shown in the inset C of Fig. 1(d), the D line also appears in regions of

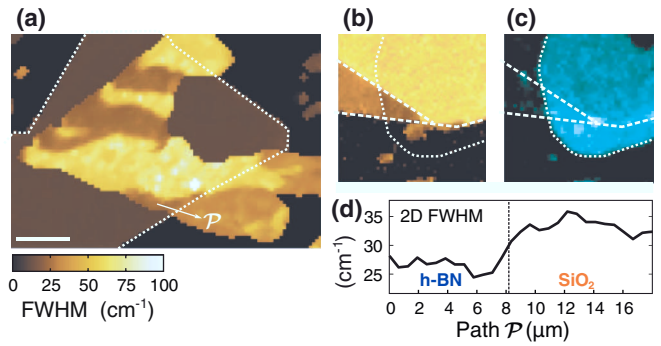


FIG. 2. (Color online) (a) 2D FWHM Raman image of the sample shown in Fig. 1(c). Where no 2D peak was found, the hBN peak FWHM was plotted making the hBN flake visible (highlighted by white dotted lines). (b) Raman map of the 2D FWHM of the sample shown in Fig. 1(b) [see white dashed box in Fig. 1(b)]. Dotted line marks the hBN substrate. (c) Raman map of the same sample: integrated intensity of the hBN peak. (d) Line cut along the solid arrow (path P) in panel (a).

substrate transition, i.e., at the edge of the underlying hBN flake. This can be attributed to local bending of the graphene flake induced by the level difference of the two substrates. The *sp*^{2+ η} hybrid orbitals necessary to bend the graphene layer cause short-range scattering leading to a D peak in the Raman spectrum. The D line is not visible in regions of graphene away from the edges, neither on hBN nor on SiO₂. We conclude that the transfer technique used in the fabrication process does not induce a significant amount of defects in the graphene lattice.

In order to show the substrate dependence of the Raman lines of graphene, we compare in Figs. 1(e) and 1(f) the G and 2D lines of a flake that partially rests on hBN and partially on SiO₂. The G peak of graphene on hBN and the one on SiO₂ differ significantly in their position: the G peak on SiO₂ is centered at 1586.5 cm⁻¹ while the one on hBN is centered at 1582.8 cm⁻¹. This downshift can be attributed to reduced doping, which also is consistent with the increase of the full width at half maximum (FWHM) of the G peak of graphene on hBN.²⁹ The FWHM is 12.2 cm⁻¹ on SiO₂ and 16.7 cm⁻¹ on hBN. Also the 2D peak shows a substrate dependence of the position which is 2674.0 cm⁻¹ on SiO₂ and 2681.6 cm⁻¹ on hBN. The substrate dependence of the 2D FWHM is even more significant, being 36.4 cm⁻¹ on SiO₂ and 28.1 cm⁻¹ on hBN.

The peak shifts and changes in the FWHM can not only be seen in individual Raman spectra, but also appear spatially resolved in two-dimensional Raman maps. A Raman map of the 2D FWHM of the sample presented in Fig. 1(c) is shown in Fig. 2(a). One can identify three single-layer regions with a FWHM below 40 cm⁻¹, two resting on hBN and one resting on SiO₂ with a small region also resting on hBN. A line cut in this substrate transition region shown in Fig. 2(d) reveals a locally resolved difference of the FWHM of around 8 cm⁻¹. Figure 2(b) shows the 2D FWHM map of the sample previously shown in Fig. 1(b) (left panel). There is also a substrate dependency visible. A Raman map of the integrated peak intensity between 1360 and 1370 cm⁻¹ is shown in Fig. 2(c). The bright area has exactly the same shape as the

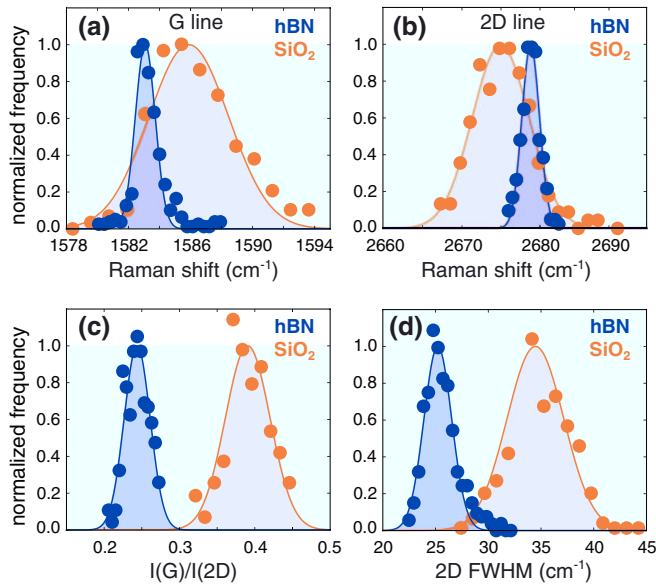


FIG. 3. (Color online) Statistical evaluation of single-layer regions of the Raman map shown in Fig. 2(a) in terms of G-peak position (a), 2D peak position (b), intensity ratio between G and 2D peak (c), and FWHM of the 2D peak (d).

underlying hBN flake in the optical picture and verifies the attribution of this peak to the hBN mode.

C. Statistical analysis

To relate the quantitative results of the measurements to physical properties like charge-carrier density fluctuations and to dispose of statistical fluctuations, it is necessary to evaluate a large number of spectra statistically. The statistical distribution of the G-peak position of the flake of Fig. 1(c), only considering single-layer regions, is plotted in Fig. 3(a). These data show a clear distinction between the different substrates. To obtain estimates of the statistical parameters the distribution is considered to be approximately Gaussian. The mean value of the distribution on hBN, $\mu_{\text{hBN}} = 1583.1 \text{ cm}^{-1}$, is redshifted with respect to the one on SiO₂, $\mu_{\text{SiO}_2} = 1585.9 \text{ cm}^{-1}$, a notable deviation by almost three wave numbers. Even more pronounced is the difference in the standard deviation which is a measure for the G-peak fluctuations. Being $\sigma_{\text{hBN}} = 0.7 \text{ cm}^{-1}$ on hBN, it is almost four times smaller than on SiO₂ where $\sigma_{\text{SiO}_2} = 2.7 \text{ cm}^{-1}$.

Previous Raman measurements with gated graphene flakes on SiO₂ have demonstrated a dependency of the G-peak position on the charge-carrier density.^{5,30} A nonadiabatic theory was established to calculate the G-peak shift in terms of charge-carrier densities.^{19,31} By using a finite temperature of 295 K and an intrinsic G-peak position of 1582.5 cm^{-1} according to Ref. 30, we obtain a charge-carrier density of $1.8 \times 10^{12} \text{ cm}^{-2}$ on SiO₂ and $9 \times 10^{11} \text{ cm}^{-2}$ on hBN, meaning the overall doping of the investigated single-layer flake on hBN is reduced by a factor of 2 with respect to a region of the very same flake resting on SiO₂. Please note that the doping induced G-peak shifts are well consistent with the observed FWHMs of the corresponding G lines.^{5,29}

Furthermore, using the standard deviation of the G-peak-shift distribution to quantify the charge fluctuations, one obtains a fluctuation of $1.6 \times 10^{12} \text{ cm}^{-2}$ on SiO₂ and a fluctuation of $6 \times 10^{11} \text{ cm}^{-2}$ on hBN. This difference by almost a factor of 3 indicates a significant reduction in doping domain fluctuations and hence a reduction of the disorder potential in the single-layer graphene on hBN. Comparing these results with the data obtained by scanning tunneling spectroscopy,^{10,11} one will notice a difference by one to two orders of magnitude. However, the experiments using scanning tunneling spectroscopy, besides being carried out in a low-temperature controlled environment, acquire data with an atomic resolution from an area of 100 nm^2 which is on the scale of individual charge puddles, the Raman setup with a spatial resolution of around 500 nm is capable of measuring on a micrometer scale averaging over a large number of charge puddles. For instance, the areas used to acquire the data on this sample are around $50 \mu\text{m}^2$ on SiO₂ and around $100 \mu\text{m}^2$ on hBN.

As shown in previous works, the reduced doping fluctuations are also manifested in a reduced ratio between the integrated peak intensities of the G and 2D peak.^{30,32} The statistical distribution depicted in Fig. 3(c) shows a clear substrate dependency of this ratio and is in qualitative agreement with the G-peak evaluation.

Experimental data of the statistics of the FWHM of the 2D line is provided in Fig. 3(d). The mean values for the two substrates are clearly different and also the standard deviations differ. Consistent with the two-dimensional Raman map shown before, the 2D peak width of the regions on hBN ($\mu_{\text{hBN}} = 25.2 \text{ cm}^{-1}$) is significantly smaller by almost 10 cm^{-1} than the one on SiO₂ ($\mu_{\text{SiO}_2} = 34.5 \text{ cm}^{-1}$). Also the fluctuations of the hBN data, $\sigma_{\text{hBN}} = 1.3 \text{ cm}^{-1}$, are significantly smaller than the ones of the SiO₂ data, $\sigma_{\text{SiO}_2} = 2.77 \text{ cm}^{-1}$. So far, the FWHM of the 2D peak was not considered to be doping dependent. Measurements of gated graphene on SiO₂ showed no significant dependence on the charge-carrier density.⁵ Hence, a reduced doping alone cannot explain this substrate dependence. A similar reduced linewidth of the 2D line (23 cm^{-1}) was observed for suspended graphene.^{21,55} We assume that the increased FWHM for graphite on SiO₂ is due to the substrate roughness and the presence of impurities which gives rise to an enhanced electron scattering and thus a smaller lifetime of the excited electronic states during the double-resonant Raman process.⁵⁷

III. DISCUSSION

We now turn to the discussion of the 2D-line position whose statistical distribution on hBN and on SiO₂ is shown in Fig. 3(b). While the position of the G line can be directly related to the presence or absence of residual charging due to impurities on or in the substrate, the interpretation of the 2D line shift is more subtle. Small charge densities ($< 4 \times 10^{12} \text{ cm}^{-2}$) lead to shifts of the 2D line by at most 2 cm^{-1} (Ref. 5). Furthermore, the 2D-line positions of suspended graphene²¹ and graphene on hBN differ by almost 10 cm^{-1} even though both systems are mostly free of charge impurities, as demonstrated by the coincidence of the G-line

positions. Thus, we discard charging as the origin for the 2D-line shift.

Our interpretation of the 2D-line shift is based on the double-resonance Raman model of Thomsen and Reich.³³ The model successfully describes the D and 2D dispersion as a function of laser energy as well as the splitting of the 2D line for bilayer, and few-layer graphene,^{16,17,34} provided that renormalization of the highest optical-phonon branch (HOB) due to electron-correlation effects is properly taken into account.³⁵ According to the double-resonance model, the 2D-line dispersion is proportional to the slope of the HOB between the high-symmetry points K and M , and inversely proportional to the slope of the π bands around K . In a first step, we thus calculated the electronic band structure and the phonon dispersion of graphene on hBN using standard density-functional theory in the local-density approximation (DFT-LDA). We chose the most stable configuration where one carbon atom is on top of a boron atom and the other carbon atom is in the hollow site of hBN.³⁷ In the electronic band structure a small gap of 53 meV opens at K but further away from K , the π bands remain almost unchanged.³⁷ In the phonon dispersion, calculated by density-functional perturbation theory (DFPT),³⁸ there is only a small change of the HOB in the immediate neighborhood around K . There, one observes a slight smearing of the Kohn anomaly (due to the very small band-gap opening), manifest in an upshift of the HOB by about 3 cm^{-1} . Everywhere else between K and M , in particular in the wave-vector range that is sampled in Raman experiments, the upshift of the HOB is less than 1 cm^{-1} . We conclude that the pure “mechanical” interaction alone between graphene and the hBN substrate cannot explain the blueshift of the Raman 2D line.³⁹

In recent work, it was shown by calculations on the level of the GW approximation⁴¹ that electronic correlation beyond DFT-LDA influences both the slope of the π bands of graphene^{42,43} and the slope of the highest-optical-phonon branch around K .³⁵ The electron-electron interaction depends on the electronic screening by the environment. Therefore, we expect that correlation effects in graphene will be reduced by a dielectric substrate. Although SiO_2 and hBN have both roughly the same dielectric constant, the coupling between graphene and ultraflat hBN is significantly increased compared to graphene on rough SiO_2 [see also illustration in Fig. 1(a)]. This different dielectric environment will have consequences for the Fermi velocity and for the electron-phonon coupling. In order to verify this hypothesis, we have performed GW calculations on isolated (suspended) graphene and on graphene surrounded by two layers of hBN. The periodic geometry that we used in our calculations is shown in Fig. 4(a). For simplicity, we have symmetrized the unit cell by choosing an ABC stacking sequence for the three layers. This ensures that the two carbon atoms in the unit cell are equivalent, each with a boron atom on one side and a hollow site on the other side. Due to the symmetry, the linear crossing of the π bands is preserved and we can use the same strategy as in Ref. 31 for the calculation of the electron-phonon coupling at the high-symmetry point K : In the $\sqrt{3} \times \sqrt{3}$ supercell, the atoms are displaced by a small distance ($d = 0.0053 \text{ \AA}$) from their equilibrium position along the eigenvector of the HOB [see Fig. 3(b) of Ref. 31]. The squared electron-phonon (e -ph)

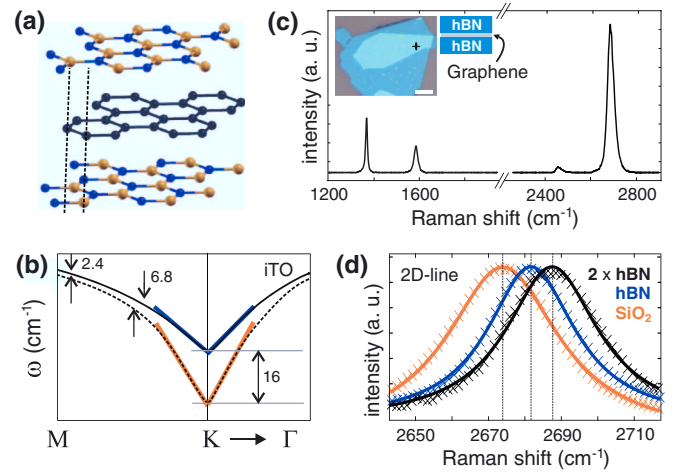


FIG. 4. (Color online) (a) Geometry employed for the calculation of the electron-phonon coupling in graphene surrounded by hBN. (b) Schematic figure of the differences in the highest-optical phonon branch around K between suspended graphene and graphene surrounded by hBN. (c) Raman spectrum of graphene surrounded on both sides by multilayer hBN. The sample is shown in the left inset. The darker-blue area is the region of graphene on an underlying hBN flake. In the light-blue area, an additional hBN layer is deposited on top of the graphene layers. The spot where the spectrum was measured is marked by the black cross and the scale bar is $5 \mu\text{m}$. (d) Raman 2D line of graphene on SiO_2 , graphene on hBN, and graphene surrounded by hBN.

coupling, which determines the slope of the HOB around K ,²⁶ is then obtained as

$$\langle D_{\mathbf{K}}^2 \rangle = \frac{1}{8} \left(\frac{\Delta E_{\mathbf{K}}}{d} \right)^2, \quad (4.1)$$

where $\Delta E_{\mathbf{K}}$ is the induced energy gap between the π^* and π bands at K .

In Table I, we present the results of our calculations (see the Appendix for details). On the LDA level, the e -ph coupling is 3.7% weaker for graphene surrounded by hBN than for pure (suspended) graphene. This difference is increased to 8% on the level of the GW approximation. Obviously, the increased screening by the hBN substrate reduces the gap opening and thus the e -ph coupling.⁴⁵ Since the slope of the HOB around K is proportional to the e -ph coupling²⁶ and since the frequency of the HOB far away from K is almost independent of screening effects,³⁵ a reduction of the e -ph coupling leads to an increase of the HOB frequency at and around K .

TABLE I. Calculated band-gap opening (for a displacement $d = 0.0053 \text{ \AA}$) and electron-phonon coupling of the highest optical (A_1') phonon at K . Comparison of LDA and GW calculations.

		Isolated Graphene	graphene surrounded by hBN
$\Delta E_{\mathbf{K}}$ (eV)	LDA	0.1414	0.1388
	GW	0.2158	0.2070
$\langle D_{\mathbf{K}}^2 \rangle$ ($\text{eV}^2/\text{\AA}^2$)	LDA	89.25	86.00
	GW	207.88	191.27

This is demonstrated in Fig. 4(b). In order to quantitatively understand this effect, it would be desirable to calculate the exact phonon dispersion relation including correlation effects. Due to the complexity of total-energy GW calculations, this is currently not feasible. A workaround consists of the use of the hybrid B3LYP functional⁴⁸ where we adjust the parameters in order to mimic the two different screening values for “pure” and “sandwiched” graphene (see details in the Appendix). Using these functionals, we obtain that the HOB shifts (from “pure” to “sandwiched” graphene) by $+16 \text{ cm}^{-1}$ at K , by $+2.4 \text{ cm}^{-1}$ at M , and by $+6.8 \text{ cm}^{-1}$ half way between K and M (which corresponds to an excitation energy of 2.8 eV). At the same time, the frequency at Γ remains almost unchanged (-0.4 cm^{-1}). For the laser energy of 2.33 eV, linear interpolation yields a phonon shift of $+8.3 \text{ cm}^{-1}$. The corresponding 2D-line shift (where two phonons are excited/absorbed) would be then $+16.6 \text{ cm}^{-1}$. These calculations are not meant to provide absolute numbers for the 2D-line shift but they demonstrate that the experimentally measured 2D-line shift qualitatively agrees with the shift that is induced by the enhanced dielectric screening for graphene on hBN.⁵³

So far, we have compared a calculation for graphene surrounded by hBN with experiments where graphene is deposited on top of a hBN flake. This motivated us to perform Raman measurements on graphene surrounded by hBN on both sides. We achieved this by the deposition of an additional multilayer hBN flake on top of one of our graphene on hBN samples. The resulting Raman spectrum is shown in Fig. 4(c). The spectrum displays three prominent peaks: the peak at 1367 cm^{-1} is the E_{2g2} mode of hBN. The G line of graphene at 1583.7 cm^{-1} is approximately in the same position as the G line of graphene with hBN on one side. This evidences that only a few additional charge impurities are added during the deposition of the top-hBN flake. In contrast to the G line, the 2D line of surrounded graphene around 2687.4 cm^{-1} is considerably blueshifted by 7 cm^{-1} compared to the 2D line of one-sided graphene on hBN as shown in Fig. 4(d). With respect to suspended graphene (2673.5 cm^{-1})²¹ the blueshift of the 2D line of graphene on hBN roughly doubles when a second hBN layer is added on top. This is another indication that the blueshift has its origin in the screening dependence of the HOB between K and M .

IV. CONCLUSION

Our Raman measurements confirm that hBN is a high-quality insulating substrate for graphene with strongly reduced impurity charging. This is evidenced by the redshift of the G peak with respect to graphene on a standard SiO_2 substrate. In contrast to the G line, the 2D line of graphene on hBN is blueshifted. We have shown that this change in the frequency of the highest optical-phonon branch is not a consequence of a direct (mechanical) interaction between graphene and its substrate. It is rather an indirect, electronic, effect mediated by the influence of the dielectric screening on the electronic structure of graphene. Usually, in three-dimensional metallic systems, the phonon frequencies close to a Kohn anomaly depend only on the *internal* screening of the (bulk) material. Layered graphene is an example where (close to the Kohn anomaly at K), the frequencies of the highest optical-phonon

branch depend on the *external* screening by the dielectric environment. This constitutes a new physical paradigm that is worthwhile to investigate also in other layered materials. The electron-phonon coupling between the π bands and the highest optical-phonon branch around K can also impose a limitation on the conductivity of graphene in the high-current limit.⁵⁴ Therefore, the dielectric screening of electron-phonon coupling in two-dimensional layered materials can play a general role for transport in layered materials.

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APPENDIX: DETAILS ON THE CALCULATIONS

The DFT calculations are performed with the code ABINIT.³⁶ Wave functions are expanded in plane waves with an energy cutoff at 35 Ha. Core electrons are replaced by Trouiller-Martins pseudopotentials. The periodic supercell comprises two layers of hBN and one layer of graphite with 20 a.u. of vacuum distance towards the neighboring slab in order to keep the interaction between neighboring slabs small. We use the experimental in-plane lattice constant of graphite, $a = 2.46 \text{ \AA}$, and “squeeze” the hBN layers to the same value in order to keep the calculations simple.

The interlayer spacing between adjacent hBN layers is 3.33 \AA (experimental value of bulk hBN) and between graphene and hBN 2.46 \AA (theoretical value, obtained from geometry optimization of graphene on hBN). For the calculations of “isolated” graphene, we use the same supercell, just removing the hBN layers. The spacing between the graphene layers is thus the same in both cases. In one case, there is vacuum between the layers, in the other case, the vacuum is “filled” with hBN layers. The Brillouin zone is sampled with a $21 \times 21 \times 1$ k-point grid. The GW calculations have been done with the code YAMBO,⁴⁴ using the plasmon-pole approximation for the dielectric constant. The same convergence parameters as in Ref. 31 are used in the present work. The values for the electron-phonon coupling for pure graphene in Table I are slightly different than in Ref. 31 due to the different spacing between the layers which leads to a difference in the (average) dielectric constant.

The B3LYP exchange-correlation energy has the following form:

$$E_{xc} = (1 - a)(E_x^{\text{LDA}} + bE_x^{\text{BECKE}}) + aE_x^{\text{HF}} + (1 - c)E_c^{\text{VWN}} + cE_c^{\text{LYP}},$$

where E_x^{BECKE} is the GGA (generalized-gradient approximation) exchange potential by Becke,⁴⁹ E_x^{HF} is the Hartree-Fock exchange potential, E_c^{VWN} is the LDA correlation potential by Vosko, Wilk, and Nusair,⁵⁰ and E_c^{LYP} is the GGA correlation potential by Lee, Yang, and Parr.⁵¹ The usual choice of the

mixing parameters is $a = 0.2, b = 0.9, c = 0.81$. The parameter a determines the admixture of Hartree-Fock exchange. Increasing a leads to a stiffening of the bonds (increasing thereby all optical-phonon frequencies). Increasing the parameter c which determines the admixture of nonlocal correlation increases the bond strength as well. We therefore change the two parameters in opposite directions in order to keep the bond strength constant. Changing the parameter a and c then mimics, roughly, a change of screening. Using the code

CRYSTAL,⁵² we fit the parameters a and c such that we obtain the same values for the e -ph coupling matrix elements, as calculated on the level of the GW approximation. For the case of isolated graphene, we obtain $a = 0.157, c = 0.1$; for the case of surrounded graphene, we obtain $a = 0.139, c = 0.81$. We emphasize that this calculation is only meant to provide a rough quantitative estimate and cannot reproduce the full physics of the dielectric screening of the Kohn anomaly of the HOB.

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